

**Search Notes**

Application/Control No.

10/069,454

Examiner

Shin-Lin Chen

Applicant(s)/Patent under  
Reexamination

ROIZ ET AL.

Art Unit

1632

**SEARCHED**

Class	Subclass	Date	Examiner
Updated		3/22/2006	<i>SLC</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated.	3/22/2006	<i>SLC</i>